

CLAIMS

We claim:

1. A millimeter- and submillimeter-wave noise apparatus comprising
a means for generating millimeter- and submillimeter-wave noise, wherein said noise
comprises one or more frequencies in the range between 110 to about 400 GHz; and
a transmission structure.
2. The apparatus of claim 1 wherein said noise further comprises one or more frequencies in
the range between about 60 to 110 GHz.
3. The apparatus of claim 2 wherein said noise is continuous across a range of frequencies
from about 60 to about 400 GHz.
4. The apparatus of claim 1 wherein said means for generating said noise comprises:
a frequency multiplier for converting microwave noise into said noise.
5. The apparatus of claim 1 wherein said means for generating said noise comprises:
a harmonic mixer.
6. The apparatus of claim 1 wherein said apparatus is portable.
7. A spectrometer comprising
the apparatus of claim 3.
8. The spectrometer of claim 7 wherein said spectrometer is a Fourier Transform
Spectrometer.
9. A method of producing millimeter- and submillimeter-wave noise comprising the steps
of:
generating a first noise band; and
converting said first noise band into a second noise band, wherein said second noise band
comprises millimeter- and submillimeter-wave noise.
10. The method of claim 9 wherein said second noise band is continuous across a range of
frequencies from about 60 to about 400 GHz.
11. The method of claim 9 wherein said second noise band is continuous across a range of
frequencies from about 60 GHz to about 1 THz.
12. The method of claim 9 wherein said first noise band comprises noise of frequencies
between about 0.1 to about 60 GHz.

13. The method of claim 9 further comprising
adjusting said first noise band to a designated power level prior to said converting step.
14. The method of claim 13 wherein said converting step comprises
inputting said adjusted first noise band into a frequency multiplier, wherein said
designated power level is a maximum safe input power level of said frequency multiplier.
15. The method of claim 13 wherein said adjusting step comprises
amplifying a power of said first noise band.
16. The method of claim 13 wherein said adjusting step comprises
attenuating a power of said first noise band.
17. The method of claim 9 further comprising
directing said second band of noise toward a destination.
18. A millimeter- and submillimeter-wave noise generating apparatus comprising:
a microwave noise source for generating microwave noise;
means for adjusting a power of said microwave noise source to a designated level; and
a frequency multiplier for converting said adjusted microwave noise into millimeter- and
submillimeter-wave noise, wherein said designated level is a maximum safe input level of said
frequency multiplier.
19. The apparatus of claim 18 wherein said means for adjusting comprises
one or more microwave amplifiers.
20. The apparatus of claim 19 wherein said means for adjusting further comprises
a level-set attenuator.
21. The apparatus of claim 18 wherein said millimeter- and submillimeter-wave noise is
continuous across a frequency range of about 60 GHz to about 400 GHz.
22. The apparatus of claim 18 wherein said millimeter- and submillimeter-wave noise is
continuous across a frequency range of about 60 GHz to about 1 THz.
23. The apparatus of claim 18 further comprising
a transmission structure coupled to an output of said frequency multiplier for directing
said millimeter- and submillimeter-wave noise.
24. The apparatus of claim 18 wherein said microwave noise source is selected from the
group consisting of: a diode noise source, a noise tube, and a thermal noise source.

25. The apparatus of claim 18 wherein said frequency multiplier is a semiconductor diode multiplier.
26. The apparatus of claim 18 wherein said apparatus is portable.
27. The apparatus of claim 18 further comprising
one or more band-pass filters coupled to said frequency multiplier to create one or more discrete millimeter- and submillimeter-wave noise bands.
28. A spectrometer comprising:
said apparatus of claim 18.
29. A method for generating millimeter and submillimeter-wave noise power comprising the steps of:
producing microwave noise power;
amplifying said microwave noise power into amplified noise power;
adjusting said amplified noise power to a designated power level; and
converting said adjusted noise power to millimeter- and submillimeter-wave noise through a frequency multiplier, wherein said designated power level is the maximum safe input level of said frequency multiplier.
30. The method of claim 29 further comprising
testing millimeter- and submillimeter-wave components using said millimeter- and submillimeter-wave noise.
31. The method of claim 29 further comprising:
directing said millimeter and submillimeter noise from said frequency multiplier into a Fourier Transform Spectrometer; and
performing Fourier Transform Spectrometry on a test sample.
32. The method of claim 29 further comprising
characterizing materials using said millimeter- and submillimeter-wave noise.
33. The method of claim 29 wherein said millimeter- and submillimeter-wave noise is continuous across the frequency range between about 60 to about 400 GHz.
34. The method of claim 29 wherein said millimeter- and submillimeter-wave noise is continuous across the frequency range between about 60 GHz to about 1 THz.

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